Notice of References Cited Application/Control No. 10/812,467 Examiner Tu M. Nguyen Applicant(s)/Patent Under Reexamination NAIK ET AL. Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-5,775,099	07-1998	Ito et al.	60/274
*	В	US-2002/0029562	03-2002	Ishii et al.	60/277
* .	С	US-6,763,657	07-2004	Wachi et al.	60/285
*	۵	US-6,722,121 '	04-2004	Gui et al.	60/285
*	E	US-5,732,554	03-1998	Sasaki et al.	60/278
*	F	US-6,336,320	01-2002	Tanaka et al.	60/285
*	G	US-6,434,929	08-2002	Nishimura et al.	60/278
*	Н	US-6,553,757	04-2003	Surnilla et al.	60/285
	1	US-			
	J	US-			
	к	US-			
	L	US-	<u> </u>		
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name .	Classification
	N					
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	Р			·		
	Q					
	R					
	s					
	Т				·	

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)								
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	w									
	x									

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.